

10/540617

PATENT APPLICATION

Express Mail Label No.: EV 725 077 41 US

JC20 Rec'd PCT/PTO 24 JUN 2005 #3

IN THE U.S. PATENT AND TRADEMARK OFFICE

June 24, 2005

Applicants : Kunio SEKIYA et al

For : METHOD FOR PROVIDING CANVAS OF PAPER-MAKING MACHINE WITH ANTI-STAINING AGENT THROUGH SPRINKLING, AND SLIDING SPRINKLE DEVICE AND ANTI-STAINING AGENT FOR USE THEREIN

PCT International Application No.: PCT/JP2003/016799

PCT International Filing Date: December 25, 2003

U.S. Application No.

(if known, see 37 CFR 1.5): Unknown

Atty. Docket No.: 4414.P0673US

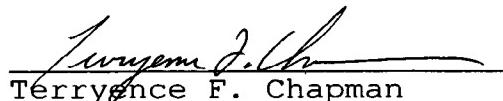
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INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is a copy of the International Search Report, Form PTO-1449 and the references cited thereon. The relevance of these references is explained on the enclosed search report. Accordingly, further comment at this point in time should not be necessary.

Respectfully submitted,


Terryence F. Chapman

TFC/smd

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Encl: Copy of International Search Report
Form PTO-1449 and one copy of each reference listed
thereon

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.H./
(00003313.DOC)

INFORMATION
DISCLOSURE
CITATION

Applicant: **Mario SEKIYA et al**
 Ser. No. **Unknown**
 Conf. No.: **Unknown**
 Group: **Unknown**
Filed: Unknown
Atty. Docket No.: 4414.P0673US

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA	4 597 526	07/01/1986	Egli et al
	AB	4 753 712	06/28/1988	Martin et al
	AC			
	AD			
	AE			
	AF			
	AG			
	AH			
	AI			
	AJ			
	AK			

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL	EP 1 124 005 A1	08/16/2001	Sekiya	
	AM	JP 2000-96476	04/04/2000		No
	AN	GB 2 284 833 A	06/21/1995	Finch	
	AO				
	AP				

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	
	AR	
EXAMINER SIGNATURE	/Mark Halpern/	DATE CONSIDERED 9/10/08

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.